## Statistical Machine Learning

Pier Francesco Palamara
Department of Statistics
University of Oxford

Slide credits and other course material can be found at: http://www.stats.ox.ac.uk/~palamara/SML\_BDI.html

#### Last time: Loss function and risk

- How good is the prediction? We can use a **loss function**  $L: \mathcal{Y} \times \mathcal{Y} \mapsto \mathbb{R}^+$  to formalize the quality of the prediction.
- Typical loss functions for regression:
  - Squared loss

$$L(Y, f(X)) = (f(X) - Y)^{2}.$$

Absolute loss

$$L(Y, f(X)) = |f(X) - Y|.$$

#### Risk

For a given loss function L, the **risk** R of a learned function f is given by the expected loss

$$R(f) = \mathbb{E}_{P_{XY}} \left[ L(Y, f(X)) \right],$$

where the expectation is with respect to the true (unknown) joint distribution of (X,Y).

• The risk is unknown, but we can compute the empirical risk:

$$R_N(f) = \frac{1}{N} \sum_{i=1}^{N} L(y_i, f(x_i)).$$

## Hypothesis space and Empirical Risk Minimization

- Hypothesis space  $\mathcal{H}$  is the space of functions f under consideration.
- Inductive bias: necessary assumptions on "plausible" hypotheses
- Find best function in the space of hypothesis  $\mathcal{H}$  minimizing the risk:

$$f_{\star} = \operatorname*{argmin}_{f \in \mathcal{H}} \mathbb{E}_{X,Y}[L(Y, f(X))]$$

• Empirical Risk Minimization (ERM): minimize the empirical risk instead, since we typically do not know  $P_{X,Y}$ .

$$\hat{f} = \underset{f \in \mathcal{H}}{\operatorname{argmin}} \frac{1}{N} \sum_{i=1}^{N} L(y_i, f(x_i))$$

• How complex should we allow functions f to be? If hypothesis space  $\mathcal H$  is "too large", ERM will overfit. Function

$$\hat{f}(x) = \begin{cases} y_i & \text{if } x = x_i, \\ 0 & \text{otherwise} \end{cases}$$

will have zero empirical risk, but is useless for generalization, since it has simply "memorized" the dataset.

## Linear regression: Solution in matrix form

#### **Compact expression**

$$R_N(\boldsymbol{\theta}) = ||\boldsymbol{X}\boldsymbol{\theta} - \boldsymbol{y}||_2^2 = \left\{\boldsymbol{\theta}^{\mathrm{T}}\boldsymbol{X}^{\mathrm{T}}\boldsymbol{X}\boldsymbol{\theta} - 2\left(\boldsymbol{X}^{\mathrm{T}}\boldsymbol{y}\right)^{\mathrm{T}}\boldsymbol{\theta}\right\} + \mathrm{const}$$

#### **Gradients of Linear and Quadratic Functions**

- $lackbox{} \nabla_{oldsymbol{x}} oldsymbol{b}^{ op} oldsymbol{x} = oldsymbol{b}$

#### **Normal equation**

$$\nabla_{\boldsymbol{\theta}} R_N(\boldsymbol{\theta}) \propto \boldsymbol{X}^{\mathrm{T}} \boldsymbol{X} \boldsymbol{\theta} - \boldsymbol{X}^{\mathrm{T}} \boldsymbol{y} = 0$$

This leads to the linear regression solution<sup>1</sup>

$$oldsymbol{ heta} = \left( oldsymbol{X}^{\mathrm{T}} oldsymbol{X} 
ight)^{-1} oldsymbol{X}^{\mathrm{T}} oldsymbol{y}$$

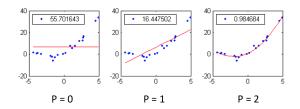
<sup>&</sup>lt;sup>1</sup>Also see PRML book, Section 3.1.2 for a geometric interpretation.

#### Nonlinear basis functions

#### Can we learn non-linear functions? We can use a nonlinear mapping

$$\boldsymbol{\phi}(\boldsymbol{x}): \boldsymbol{x} \in \mathbb{R}^D 
ightarrow \boldsymbol{z} \in \mathbb{R}^M$$

For instance, we could use polynomials of increasing order,  $\phi_k(x_i) = x_i^k$ 

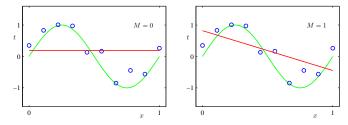


#### The linear regression solution has a new design matrix

$$oldsymbol{\Phi} = \left(egin{array}{c} oldsymbol{\phi}(oldsymbol{x}_1)^{ ext{T}} \ oldsymbol{\psi}(oldsymbol{x}_N)^{ ext{T}} \ oldsymbol{\phi}(oldsymbol{x}_N)^{ ext{T}} \end{array}
ight) \in \mathbb{R}^{N imes M}, \quad oldsymbol{ heta}^{ ext{LMS}} = oldsymbol{\left(\Phi^{ ext{T}} oldsymbol{\Phi}
ight)}^{-1} oldsymbol{\Phi}^{ ext{T}} oldsymbol{y}$$

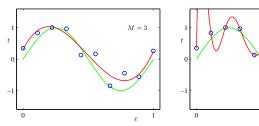
## Regression with nonlinear basis functions

Fitting samples from a sine function: underrfitting as f(x) is too simple



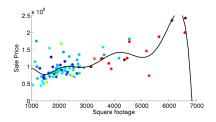
M = 9

Better fit for higher order, but overfitting as f(x) is too flexible



## Overfitting can be quite disastrous

#### Fitting the housing price data with M=7



Note that the price would go to zero (or negative) if you buy bigger ones! **This is called poor generalization/overfitting.** 

# Validation and Cross-Validation

### Generalization

- Generalization ability: what is the out-of-sample (testing) error of the learner f?
- Two important factors determining generalization ability:
  - Model complexity
  - Training data size
- We learn f by minimizing some variant of empirical risk  $R_N^{\sf emp}(f)$  what can we say about the true risk R(f)?

## **Empirical vs True Risk**

In general,

$$R(f) = R_N^{\text{emp}}(f) + \text{overfit penalty}.$$

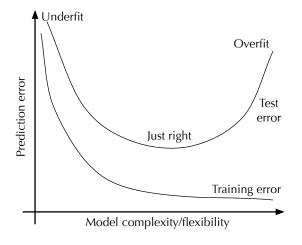
- Overfit penalty depends on the complexity of the model (also see Vapnik-Chervonenkis, or VC theory).
- We will look at two strategies to tune a model's complexity:
  - (Cross-)Validation, where we estimate R(f) to calibrate the model
  - Regularization, where we try to approximate a model's overfit penalty
- testing error can be obtained by setting aside some of the data.
  - testing error ≠ training error.
  - For any example not used in training:

$$\mathbb{E}\left[L\left(y_{\mathsf{test}}, f(x_{\mathsf{test}})\right)\right] = R(f).$$

But for examples used in training:

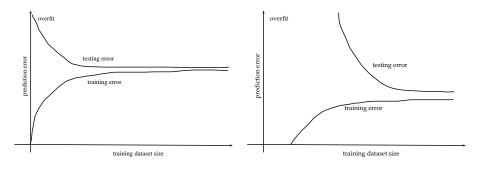
$$\mathbb{E}\left[L\left(y_{\mathsf{train}}, f(x_{\mathsf{train}})\right)\right] \neq R(f).$$

## Learning Curves



Fixed dataset size, varying model complexity.

## Learning Curves

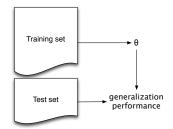


Fixed model complexity, varying dataset size.

Two models: one simple, one complex. Which is which?

## **Optimizing Tuning Parameters**

- How can we optimize generalization ability, via optimizing choice of tuning parameters, model size, and learning parameters?
- Suppose we have split data into training/test set.
- Test set can be used to determine generalization ability, and used to choose best setting of tuning parameters/model size/learning parameters with best generalization.
- Once these tuning parameters are chosen, still important to determine generalization ability, but cannot use performance on test set to gauge this anymore!



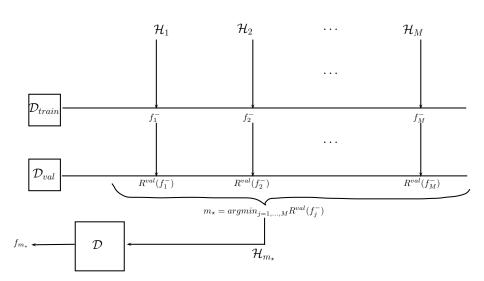
### Validation error

- Idea: split data into 3 sets: training set, test set, and validation set.
- Out-of-sample average loss. For a dataset  $\{\tilde{x}_i, \tilde{y}_i\}_{i=1}^v$  unseen in training

$$R^{\mathsf{val}}(f) = \frac{1}{v} \sum_{i=1}^{v} L\left(\tilde{y}_i, f(\tilde{x}_i)\right)$$

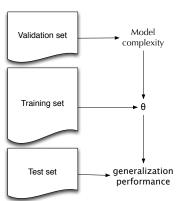
- $\bullet \ \mathbb{E}\left[R^{\mathsf{val}}(f)\right] = R(f), \, \mathsf{Var}\left[R^{\mathsf{val}}(f)\right] \asymp \tfrac{1}{v}, \, \mathsf{i.e.} \ R^{\mathsf{val}}(f) = R(f) \pm \mathcal{O}\left(\tfrac{1}{\sqrt{v}}\right)$
- Just like testing error so far.
- It becomes validation error only once it is used to change our learning.

### **Validation**



#### **Validation**

- For each combination of tuning parameters  $\gamma$ :
  - Train our model on the training set, fit parameters  $\theta = \theta(\gamma)$ , obtaining decision function  $f_{\theta(\gamma)}$ .
  - Evaluate  $R^{\text{val}}\left(f_{\theta(\gamma)}\right)$  average loss on a validation set.
- Pick  $\gamma^*$  with best performance on validation set.
- Using  $\gamma^*$ , train on both training and validation set to obtain the optimal  $\theta^*$ .
- $R^{\text{val}}(f_{\theta(\gamma^*)})$  is now a biased estimate of  $R(f_{\theta(\gamma^*)})$  and can be overly optimistic!
- Evaluate model with  $\gamma^*$ ,  $\theta^*$  on test set, reporting generalization performance.



## Bias introduced by validation

• **Example**: Selecting between two equally bad classifiers  $f_1$  and  $f_2$ :

$$R(f_1) = R(f_2) = 0.5.$$

- Assume that we have independent unbiased estimators  $\mathsf{R}_1 = R^{\mathsf{val}}(f_1)$ ,  $\mathsf{R}_2 = R^{\mathsf{val}}(f_2)$ , both uniform on [0,1]
- Learning rule  $f_{\star}$  chosen to minimize  $R^{\text{val}}$  is either  $f_1$  or  $f_2$ , so also equally bad.
- But  $\mathbb{E}\min(\mathsf{R}_1,\mathsf{R}_2)=\frac{1}{3}$  (since  $\mathbb{E}\min(\{U_{[0,1]}\}_{i=1}^n)=(n+1)^{-1}$ ), so in terms of validation error it may appear that we are getting an improvement!

#### Validation error and Generalization

How contaminated are different parts of data in terms of being able to tell us something about generalization ability?

- Training data: fully contaminated, used in learning  $R^{emp}(f)$  is usually far from R(f) (unless the model is too simple for the amount of data).
- Validation data: partly contaminated, used in model selection / meta-learning - R<sup>val</sup>(f) is biased, but still useful, provided that:
  - ullet we have a large enough validation set size v
  - ullet we do not use it to select from a large number M of models
  - Typically,

$$R(f) \leq R^{\mathrm{val}}(f) + \underbrace{\mathcal{O}\left(\sqrt{\frac{\log M}{v}}\right)}_{\text{overfit penalty of the meta-model}}$$

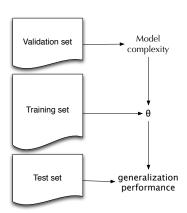
Test data: clean, not used for any part of learning.

### Size of validation set?

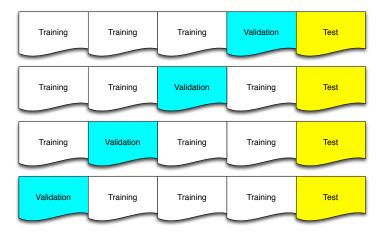
- In practice, there is just one dataset! If v is used for computing validation error, then only n-v used for training.
  - Small  $v: R^{\text{val}}(f^-)$  is a bad estimate of  $R(f^-)$
  - Large  $v: R^{\text{val}}(f^-)$  is a reliable estimate of a much worse risk ( $f^-$  learned on much less data than f)!
- We are using:

$$R(f) \underset{(\mathsf{need \ small} \ v)}{\approx} R(f^-) \underset{(\mathsf{need \ large} \ v)}{\approx} R^{\mathsf{val}}(f^-)$$

- Wasteful to split into 3 subsets.
- Different approach: cross-validation.



#### **Cross-Validation**



### **Cross-Validation**

- Basic approach:
  - Split training set into T folds.
  - For each  $\gamma$  and each  $t = 1, \dots, T$ :
    - Use fold t as validation set and the rest to train the model parameters  $\theta_t(\gamma)$ , obtaining trained learner  $f_{t,\gamma}^-$ .

$$R_t^{\mathrm{val}}(f_{t,\gamma}^-) = \frac{1}{|\mathsf{Fold}(t)|} \sum_{i \in \mathsf{Fold}(t)} L(y_i, f_{t,\gamma}^-(x_i))$$

• Choose  $\gamma^*$  which minimizes validation error averaged over folds

$$\frac{1}{T} \sum_{t=1}^{T} R_t^{\text{val}}(f_{t,\gamma}^-)$$

- Train model with tuning parameter  $\gamma^*$  on all training set to obtain  $f_{\gamma^*}$ .
- Report generalization performance on test set.
- Leave-One-Out (LOO) cross validation: one data item per fold, i.e., T=n.

Cross-validation can be computationally expensive ( $T \times$  increase in complexity).

#### Leave-One-Out Cross-Validation

**Leave-one-out (LOO)** cross validation: one data item per fold, i.e., T = n.

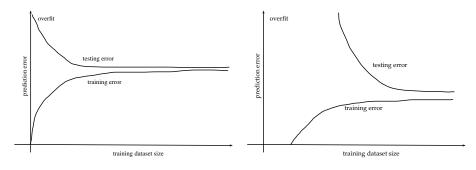
- Since only one data item not used in training,  $R(f_{t,\gamma}^-)$  are all very close to  $R(f_{\gamma})$  (small v benefit).
- Thus,

$$\frac{1}{n} \sum_{t=1}^{n} R_{t}^{\text{val}}(f_{t,\gamma}^{-}) = \frac{1}{n} \sum_{t=1}^{n} L(y_{t}, f_{t,\gamma}^{-}(x_{t}))$$

has a small variance (large v benefit).

- All examples for validation and all examples for training.
- summands are no longer independent

## **Learning Curves**



Fixed model complexity, varying dataset size. Two models: one simple, one complex. Which is which?

### **Bias-Variance Tradeoff**

- Where does the prediction error come from?
- Example: Squared loss in regression:  $\mathcal{X} = \mathbb{R}^p$ ,  $\mathcal{Y} = \mathbb{R}$ ,

$$L(Y, f(X)) = (Y - f(X))^2$$

Optimal f is the conditional mean:

$$f_*(x) = \mathbb{E}\left[Y|X=x\right]$$

ullet Follows from  $R(f) = \mathbb{E}_X \mathbb{E}\left[\left.(Y - f(X))^2\right|X\right]$  and

$$\mathbb{E}\left[\left.(Y - f\left(X\right)\right)^{2}\right| X = x\right]$$

$$= \mathbb{E}\left[\left.Y^{2}\right| X = x\right] - 2f\left(x\right) \mathbb{E}\left[\left.Y\right| X = x\right] + f\left(x\right)^{2}$$

$$= \operatorname{Var}\left[Y|X = x\right] + \left(\mathbb{E}\left[\left.Y\right| X = x\right] - f(x)\right)^{2}.$$

### **Bias-Variance Tradeoff**

• Optimal risk is the intrinsic conditional variability of *Y* (noise):

$$R(f_*) = \mathbb{E}_X \left[ \mathsf{Var} \left[ Y | X \right] \right]$$

Excess risk:

$$\begin{split} R(f) - R(f_*) &= \mathbb{E}_X \left[ \mathsf{Var} \left[ Y | X \right] + \left( f_*(X) - f(X) \right)^2 - \mathsf{Var} \left[ Y | X \right] \right] \\ &= \mathbb{E}_X \left[ \left( f(X) - f_*(X) \right)^2 \right] \end{split}$$

- How does the excess risk behave on average?
- Consider a randomly selected dataset  $\mathcal{D} = \{(X_i, Y_i)\}_{i=1}^n$  and  $f^{(\mathcal{D})}$  trained on  $\mathcal{D}$  using a model (hypothesis class)  $\mathcal{H}$ .

$$\mathbb{E}_{\mathcal{D}}\left[R(f^{(\mathcal{D})}) - R(f_*)\right] = \mathbb{E}_{\mathcal{D}}\mathbb{E}_X\left[\left(f^{(\mathcal{D})}(X) - f_*(X)\right)^2\right]$$
$$= \mathbb{E}_X\mathbb{E}_{\mathcal{D}}\left[\left(f^{(\mathcal{D})}(X) - f_*(X)\right)^2\right].$$

#### **Bias-Variance Tradeoff**

• Denote  $\bar{f}(x)=\mathbb{E}_{\mathcal{D}}f^{(\mathcal{D})}(x)$  (average decision function over all possible datasets)

$$\mathbb{E}_{\mathcal{D}}\left[\left(f^{(\mathcal{D})}(X) - f_*(X)\right)^2\right] = \underbrace{\mathbb{E}_{\mathcal{D}}\left[\left(f^{(\mathcal{D})}(X) - \bar{f}(X)\right)^2\right]}_{\mathsf{Var}_X(\mathcal{H}, n)} + \underbrace{\left(\bar{f}(X) - f_*(X)\right)^2}_{\mathsf{Bias}_X^2(\mathcal{H}, n)}$$

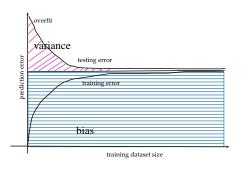
Now,

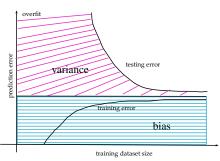
$$\mathbb{E}_{\mathcal{D}}R(f^{(\mathcal{D})}) = R(f_*) + \mathbb{E}_X \mathsf{Var}_X(\mathcal{H}, n) + \mathbb{E}_X Bias_X^2(\mathcal{H}, n)$$

Where does the prediction error come from?

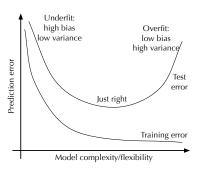
- Noise: Intrinsic difficulty of regression problem.
- Bias: How far away is the best learner in the model (average learner over all possible datasets) from the optimal one?
- Variance: How variable is our learning method if given different datasets?

# **Learning Curves**



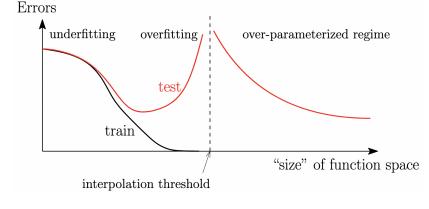


## Building models to trade bias with variance



- Building a machine learning model involves trading between its bias and variance. We will see many examples in the next lectures:
  - Bias reduction at the expense of a variance increase: building more complex models, e.g. adding nonlinear features and additional parameters, increasing the number of hidden units in neural nets, using decision trees with larger depth, decreasing the regularization parameter.
  - Variance reduction at the expense of a bias increase: early stopping, using k-nearest neighbours with larger k, increasing the regularization parameter.

## Note: double descent phenomenon



"Double descent" phenomenon in over-parameterized models, see e.g. Francis Bach's LTFP book, Section 11.2